

Notice of References Cited

Application/Control No.

10/578,776

Applicant(s)/Patent Under

Reexamination

SAKURAI ET AL.

Examiner

MATTHEW D. MATZEK

Art Unit

1794

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,495,258	12-2002	Chen et al.	428/408
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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